

Preliminary

SIDC53D120H6

Fast switching diode chip in EMCON-Technology

FEATURES:

- 1200V EMCON technology 120 µm chip
- soft, fast switching
- low reverse recovery charge
- small temperature coefficient

This chip is used for:

EUPEC power modules and discrete devices

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С

Applications:

 SMPS, resonant applications, drives

Chip Type	V _R	I _F	Die Size	Package	Ordering Code	
SIDC53D120H6	1200V	100A	7.3 x 7.3 mm ²	sawn on foil	Q67050-A4100	

MECHANICAL PARAMETER:

Raster size	7.3 x 7.3				
Area total / active	53.29 / 44.22	mm ²			
Anode pad size	6.58 x 6.58				
Thickness	120	μm			
Wafer size	150	mm			
Flat position	180	deg			
Max. possible chips per wafer	304 pcs				
Passivation frontside	Photoimide				
Anode metallisation	3200 nm Al Si 1%				
Cathode metallisation	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	Al, ≤500μm				
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



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Maximum Ratings

Parameter	Symbol	Condition	Value	Unit	
Repetitive peak reverse voltage	V_{RRM}		1200	V	
Continuous forward current limited by T_{jmax}	I _F		100		
Single pulse forward current (depending on wire bond configuration)	I _{FSM}	$t_P = 10 \text{ ms sinusoidal}$	tbd	А	
Maximum repetitive forward current limited by T _{jmax}	I _{FRM}		200		
Operating junction and storage temperature	$T_{\rm j}$, $T_{ m stg}$		-55+150	°C	

Static Electrical Characteristics (tested on chip), T_j =25 °C, unless otherwise specified

Parameter	Symbol	Condi	Value			l loit	
raidifietei	Symbol	Conditions		min.	Тур.	max.	Unit
Reverse leakage current	I_{R}	$V_R = 1200 V$	$T_j=25$ °C			250	μA
Cathode-Anode breakdown Voltage	V _{Br}	$I_R=4mA$	<i>T_j</i> =25°C	1200			V
Forward voltage drop	V _F	I _F =100A	$T_j=25$ °C		1.6		V

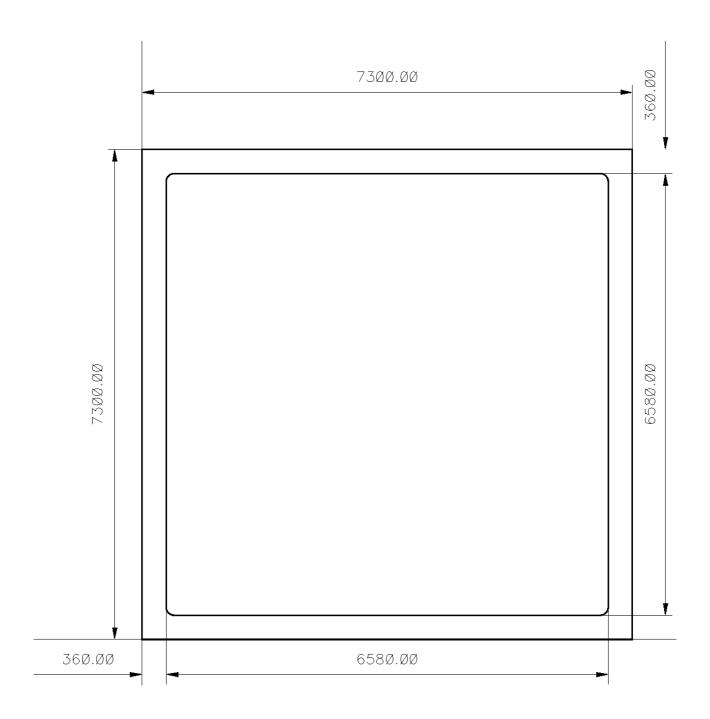
Dynamic Electrical Characteristics, at T_j = 25 °C, unless otherwise specified, tested at component

Daramatar	Cumbal	Conditions		Value			I Imit
Parameter	Symbol	Condi	tions	min.	Тур.	max.	Unit
Reverse recovery time	t _{rr1}	I _F =100A	$T_j = 25$ °C		tbd		
	t_{rr2}	$di/dt=1100A/\mathbf{m}s$ $V_R=600V$	$T_j = 125$ °C				ns
Peak recovery current	I _{RRM1}	I _F =100A	$T_j = 25$ °C		119.8		
	I _{RRM2}	$V_R = 600 V$	$T_j = 125$ °C		127.5		A
Reverse recovery charge	Q _{rr1}	I _F =100A	T _j =25°C		10		
	Q _{rr2}	$V_R = 600V$	T _j =125°C		18		μC
rocovory current	di _{rr1} /dt	$I_F = 100A$	T _j =25°C		tbd		
	di _{rr2} /dt	di/dt = 1100 A/ms $V_R = 600 V$	$T_j = 125^{\circ} \text{C}$			A/μs	
Softness	S1	I _F =100A	T _j =25°C		tbd		1
	S2	$V_R = 600 V$	T _j =125°C				



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CHIP DRAWING:





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FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the INFINEON TECHNOLOGIES / GUPEC

tbd

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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